

Search Notes**Application No.**

09/996,127

Examiner

Jacques Veillard

Applicant(s)

CHAN ET AL.

Art Unit

2165

SEARCHED

Class	Subclass	Date	Examiner
707	2-5	12/14/2004	J.V
707	6-10	12/14/2004	J.V
707	100-102	12/14/2004	J.V
706	45, 922	12/15/2004	J.V
709	203	12/15/2004	J.V
707	104.1	12/17/2004	J.V
707	200, 203	12/17/2004	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EIC Plus Database search, prepared by SIRA.	12/15/2004	J.V
West Search: US. Pat., US. Pub., EPO, JPO, Derwent, IBM TD, and NPL	12/16/2004	J.V
Search continued: ACM and IEEE database search.	12/21/2004	J.V
Consulted with 101 panel. Talk to Jack Harvey about claims 1- 8. Claims 1-7 are not statutory, specifically claim 1.	12/23/2004	J.V